# 74ABT823

# 9-bit D-type flip-flop with reset and enable; 3-state Rev. 4 — 7 November 2011 Produ

**Product data sheet** 

### **General description**

The 74ABT823 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT823 is a 9-bit wide buffered register with clock enable input ( $\overline{CE}$ ) and master reset input (MR) which are ideal for parity bus interfacing in systems using many microprocessors.

The 74ABT823 is designed to eliminate the extra packages required to buffer existing registers and provide extra data width for wider data and address paths of buses carrying parity.

The register is fully edge-triggered. The state of each D input, one set-up time before the LOW-to-HIGH clock transition, is transferred to the corresponding output Q of the flip-flop.

#### Features and benefits 2.

- High-speed parallel registers with positive edge-triggered D-type flip-flops
- Ideal where high speed, light loading, or increased fan-in are required with MOS microprocessors
- Output capability: +64 mA and -32 mA
- Power-on 3-state
- Power-on reset
- Latch-up protection exceeds 500 mA per JESD78B class II level A
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V

### **Ordering information**

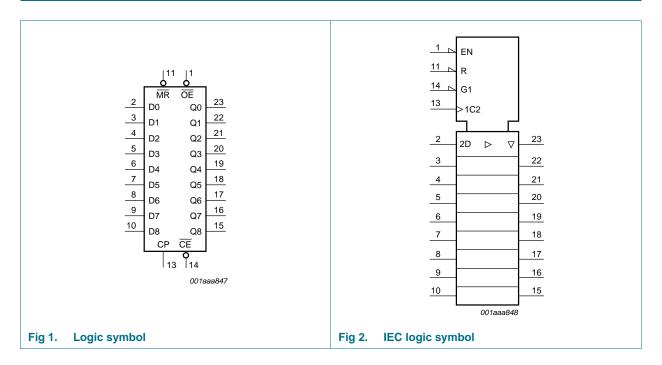
Table 1. **Ordering information** 

Type number	Package			
	Temperature range	Name	Description	Version
74ABT823D	–40 °C to +85 °C	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1
74ABT823DB	–40 °C to +85 °C	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1
74ABT823PW	–40 °C to +85 °C	TSSOP24	plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1

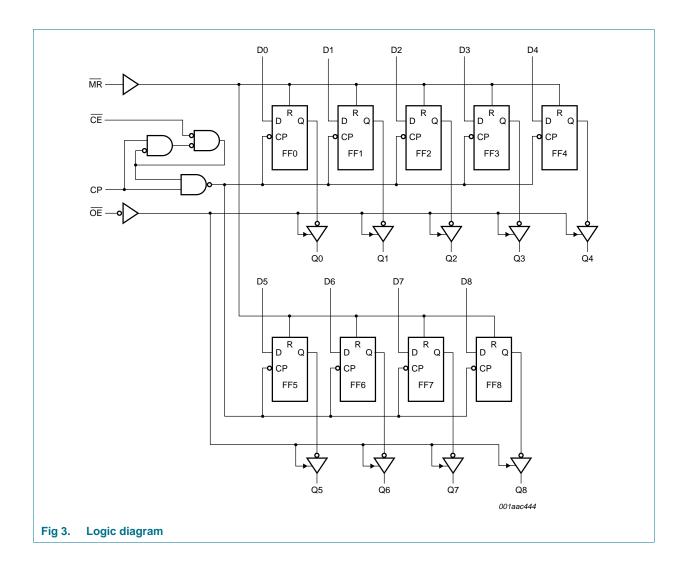


9-bit D-type flip-flop with reset and enable; 3-state

## 4. Functional diagram



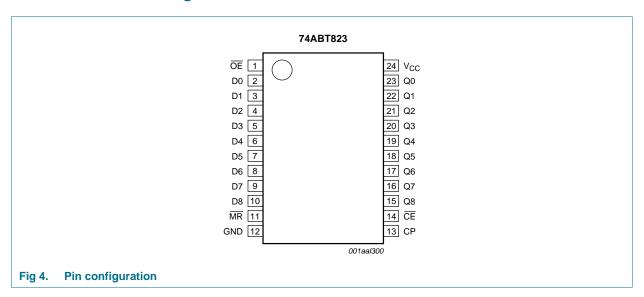
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### 5. Pinning information

### 5.1 Pinning



### 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
ŌE	1	output enable input (active LOW)
D0, D1, D2, D3, D4, D5, D6, D7, D8	2, 3, 4, 5, 6, 7, 8, 9, 10	data input
MR	11	master reset input (active LOW)
GND	12	ground (0 V)
СР	13	clock pulse input (active rising edge)
CE	14	clock enable input (active LOW)
Q8, Q7, Q6, Q5, Q4, Q3, Q3, Q2, Q1, Q0	15, 16, 17, 18, 19, 20, 21, 22, 23	data output
Vcc	24	positive supply voltage

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### 6. Functional description

#### 6.1 Function table

Table 3. Function table[1]

Input					Output	Operating mode
OE	MR	CE	СР	Dn	Qn	
L	L	X	X	X	L	clear
L	Н	L	$\uparrow$	h	Н	load and read data
L	Н	L	$\uparrow$	I	L	
L	Н	Н	NC	Χ	NC	hold
Н	Χ	Χ	Χ	X	Z	high-impedance

<sup>[1]</sup> H = HIGH voltage level;

### 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Symbol	Parameter	Conditions	Min	Max	Unit
$V_O$ output voltageoutput in OFF-state or HIGH-state[1] -0.5+5.5V $I_{IK}$ input clamping current $V_I < 0 \text{ V}$ -18-mA $I_{OK}$ output clamping current $V_O < 0 \text{ V}$ -50-mA $I_O$ output currentoutput in LOW-state-128mA	$V_{CC}$	supply voltage		-0.5	+7.0	V
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	VI	input voltage		<u>[1]</u> –1.2	+7.0	V
$I_{OK}$ output clamping current $V_O < 0 \text{ V}$ $-50$ - mA $I_O$ output current output in LOW-state - 128 mA	Vo	output voltage	output in OFF-state or HIGH-state	<u>[1]</u> –0.5	+5.5	V
I <sub>O</sub> output current output in LOW-state - 128 mA	I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V	-18	-	mA
	I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V	-50	-	mA
$T_j$ junction temperature $2$ - 150 °C	I <sub>O</sub>	output current	output in LOW-state	-	128	mA
	Tj	junction temperature		[2] _	150	°C
$T_{stg}$ storage temperature –65 +150 °C	T <sub>stg</sub>	storage temperature		-65	+150	°C

<sup>[1]</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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L = LOW voltage level;

h = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition;

I = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition;

<sup>↑ =</sup> LOW-to-HIGH clock transition;

NC = no change;

X = don't care;

Z = high-impedance OFF-state.

<sup>[2]</sup> The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

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## 8. Recommended operating conditions

Table 5. Operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CC}$	supply voltage		4.5	-	5.5	V
VI	input voltage		0	-	$V_{CC}$	V
$V_{IH}$	HIGH-level input voltage		2.0	-	-	V
$V_{IL}$	LOW-level Input voltage		-	-	0.8	V
I <sub>OH</sub>	HIGH-level output current		-32	-	-	mA
I <sub>OL</sub>	LOW-level output current		-	-	64	mA
Δt/ΔV	input transition rise and fall rate		0	-	5	ns/V
T <sub>amb</sub>	ambient temperature	in free air	-40	-	+85	°C

### 9. Static characteristics

Table 6. Static characteristics

Symbol	Parameter	Conditions			25 °C		-40 °C t	o +85 °C	Unit
				Min	Тур	Max	Min	Max	
$V_{IK}$	input clamping voltage	$V_{CC} = 4.5 \text{ V}; I_{IK} = -18 \text{ mA}$		-1.2	-0.9	-	-1.2	-	V
$V_{OH}$	HIGH-level output	$V_I = V_{IL}$ or $V_{IH}$							
	voltage	$V_{CC} = 4.5 \text{ V}; I_{OH} = -3 \text{ mA}$		2.5	2.9	-	2.5	-	V
		$V_{CC} = 5.0 \text{ V}; I_{OH} = -3 \text{ mA}$		3.0	3.4	-	3.0	-	V
		$V_{CC} = 4.5 \text{ V}; I_{OH} = -32 \text{ mA}$		2.0	2.4	-	2.0	-	V
$V_{OL}$	LOW-level output voltage	$V_{CC}$ = 4.5 V; $I_{OL}$ = 64 mA; $V_{I}$ = $V_{IL}$ or $V_{IH}$		-	0.42	0.55	-	0.55	V
$V_{OL(pu)}$	power-up LOW-level output voltage	$V_{CC}$ = 5.5 V; $I_{O}$ = 1 mA; $V_{I}$ = GND or $V_{CC}$	<u>[1]</u>	-	0.13	0.55	-	0.55	V
I	input leakage current	$V_{CC}$ = 5.5 V; $V_I$ = $V_{CC}$ or GND		-	±0.01	±1.0	-	±1.0	μΑ
I <sub>OFF</sub>	power-off leakage current	$V_{CC}$ = 0 V; $V_{I}$ or $V_{O} \le 4.5$ V		-	±5.0	±100	-	±100	μΑ
I <sub>O(pu/pd)</sub>	power-up/power-down output current	$V_{CC} = 2.0 \text{ V}; V_O = \underline{0.5} \text{ V};$ $V_I = \text{GND or } V_{CC}; \overline{\text{OE}} \text{ HIGH}$	[2]	-	±5.0	±50	-	±50	μА
l <sub>OZ</sub>	OFF-state output	$V_{CC}$ = 5.5 V; $V_I$ = $V_{IL}$ or $V_{IH}$							
	current	V <sub>O</sub> = 2.7 V		-	5.0	50	-	50	μΑ
		V <sub>O</sub> = 0.5 V		-	-5.0	-50	-	-50	μΑ
I <sub>LO</sub>	output leakage current	HIGH-state; $V_O = 5.5 \text{ V}$ ; $V_{CC} = 5.5 \text{ V}$ ; $V_I = \text{GND or } V_{CC}$		-	5.0	50	-	50	μА
Io	output current	$V_{CC} = 5.5 \text{ V}; V_{O} = 2.5 \text{ V}$	[3]	-180	-50	-50	-180	-50	mΑ
I <sub>CC</sub>	supply current	$V_{CC}$ = 5.5 V; $V_I$ = GND or $V_{CC}$							
		outputs HIGH-state		-	0.5	250	-	250	μΑ
		outputs LOW-state		-	27	34	-	34	mA
		outputs disabled		-	0.5	250	-	250	μΑ

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Table 6. Static characteristics ... continued

Symbol	Parameter	Conditions			25 °C		-40 °C t	Unit	
				Min	Тур	Max	Min	Max	
$\Delta I_{CC}$	additional supply current	per input pin; $V_{CC} = 5.5 \text{ V}$ ; one input at 3.4 V; other inputs at $V_{CC}$ or GND	<u>[4]</u>	-	0.5	1.5	-	1.5	mA
C <sub>I</sub>	input capacitance	$V_I = 0 \text{ V or } V_{CC}$		-	4	-	-	-	pF
Co	output capacitance	outputs disabled; $V_O = 0 \text{ V or } V_{CC}$		-	7	-	-	-	pF

<sup>[1]</sup> For valid test results, data must not be loaded into the flip-flops (or latches) after applying the power.

### 10. Dynamic characteristics

**Table 7. Dynamic characteristics** GND = 0 V; for test circuit, see Figure 9.

Symbol	Parameter	Conditions	25 °C;	V <sub>CC</sub> =	5.0 V	-40 °C to V <sub>CC</sub> = 5.0	o +85 °C; V ± 0.5 V	Unit
			Min	Тур	Max	Min	Max	
f <sub>max</sub>	maximum frequency	see Figure 5	125	200	-	125	-	MHz
t <sub>PLH</sub>	LOW to HIGH propagation delay	CP to Qn, see Figure 5	2.1	4.3	5.9	2.1	6.8	ns
t <sub>PHL</sub>	HIGH to LOW	CP to Qn, see Figure 5	2.2	4.4	6.1	2.2	6.7	ns
	propagation delay	MR to Qn, see Figure 6	2.0	4.1	6.3	2.0	7.1	ns
t <sub>PZH</sub>	OFF-state to HIGH propagation delay	OE to Qn; see Figure 8	1.0	3.0	4.5	1.0	5.3	ns
t <sub>PZL</sub>	OFF-state to LOW propagation delay	OE to Qn; see Figure 8	2.2	4.1	5.6	2.2	6.3	ns
t <sub>PHZ</sub>	HIGH to OFF-state propagation delay	OE to Qn; see Figure 8	2.7	4.8	6.2	2.7	6.9	ns
t <sub>PLZ</sub>	LOW to OFF-state propagation delay	OE to Qn; see Figure 8	2.5	5.0	6.4	2.5	6.9	ns
t <sub>su(H)</sub>	set-up time HIGH	Dn to CP; see Figure 7	2.1	0.5	-	2.1	-	ns
		CE to CP; see Figure 7	+2.0	-0.5	-	+2.0	-	ns
t <sub>su(L)</sub>	set-up time LOW	Dn to CP; see Figure 7	2.1	0.2	-	2.1	-	ns
		CE to CP; see Figure 7	3.3	1.5	-	3.3	-	ns
t <sub>h(H)</sub>	hold time HIGH	CP to Dn; see Figure 7	1.3	0.0	-	1.3	-	ns
		CP to CE; see Figure 7	+1.0	-1.4	-	+1.0	-	ns
t <sub>h(L)</sub>	hold time LOW	CP to Dn; see Figure 7	+1.3	-0.3	-	+1.3	-	ns
		CP to CE; see Figure 7	2.0	0.7	-	2.0	-	ns
$t_{WH}$	pulse width HIGH	CP; see Figure 5	2.9	1.9	-	2.9	-	ns

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<sup>[2]</sup> This parameter is valid for any  $V_{CC}$  between 0 V and 2.1 V, with a transition time of up to 10 ms. From  $V_{CC}$  = 2.1 V to  $V_{CC}$  = 5 V  $\pm$  10 % a transition time of up to 100  $\mu$ s is permitted.

<sup>[3]</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

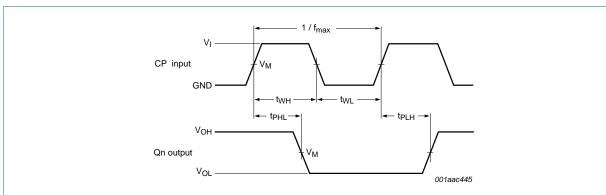
<sup>[4]</sup> This is the increase in supply current for each input at 3.4 V.

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**Table 7. Dynamic characteristics** ...continued GND = 0 V; for test circuit, see <u>Figure 9</u>.

Symbol	Parameter	Conditions	25 °C	; V <sub>CC</sub> =		-40 °C to V <sub>CC</sub> = 5.0		Unit
			Min	Тур	Max	Min	Max	
$t_{WL}$	pulse width LOW	CP; see Figure 5	3.8	2.8	-	3.8	-	ns
		MR; see Figure 6	5.5	4.0	-	5.5	-	ns
t <sub>rec</sub>	recovery time	MR to CP; see Figure 6	2.5	0.6	-	2.5	-	ns

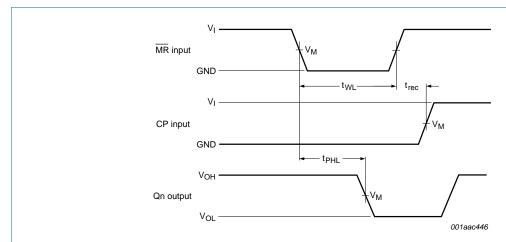
#### 11. Waveforms



 $V_{M} = 1.5 \text{ V}$ 

V<sub>OL</sub> and V<sub>OH</sub> are typical voltage output levels that occur with the output load.

Fig 5. Propagation delay clock input (CP) to output (Qn), clock pulse (CP) width and maximum clock (CP) frequency



 $V_{M} = 1.5 V$ 

 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical voltage output levels that occur with the output load.

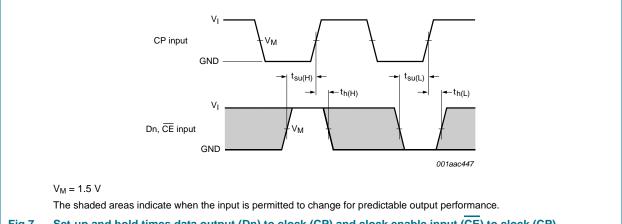
Fig 6. Master reset (MR) pulse width, propagation delay master reset (MR) to output (Qn) and recovery time master reset (MR) to clock (CP)

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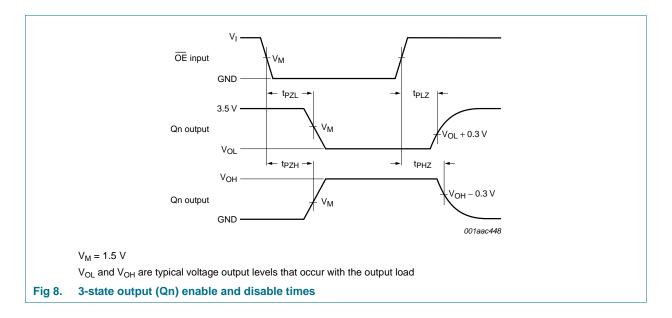
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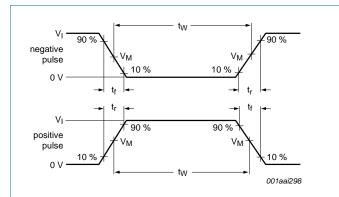


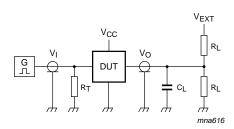
Set-up and hold times data output (Dn) to clock (CP) and clock enable input (CE) to clock (CP) Fig 7.



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#### 9-bit D-type flip-flop with reset and enable; 3-state





a. Input pulse definition

b. Test circuit

Test data is given in Table 8.

 $R_L$  = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

 $V_{\mathsf{EXT}}$  = External voltage for measuring switching times.

Fig 9. Load circuitry for switching times

Table 8. Test data

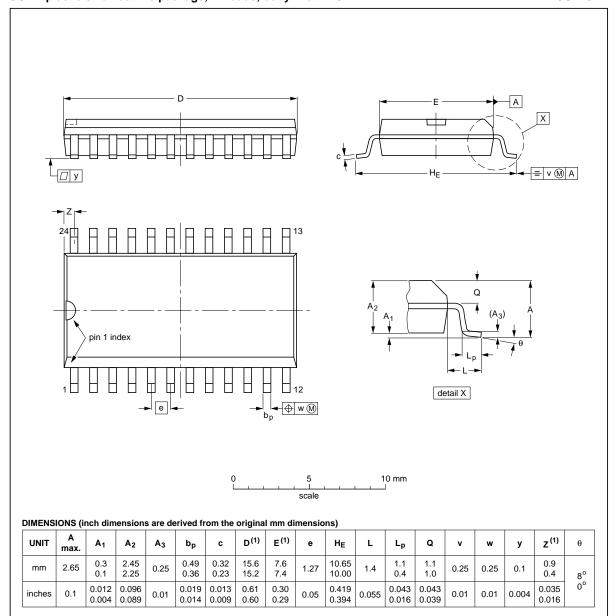
Input				Load		V <sub>EXT</sub>				
VI	f <sub>l</sub>	t <sub>W</sub>	t <sub>r</sub> , t <sub>f</sub>	CL	R <sub>L</sub>	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>		
3.0 V	1 MHz	500 ns	≤ 2.5 ns	50 pF	500 Ω	open	open	7.0 V		

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### 12. Package outline

#### SO24: plastic small outline package; 24 leads; body width 7.5 mm

SOT137-1



#### Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT137-1	075E05	MS-013			<del>99-12-27</del> 03-02-19

Fig 10. Package outline SOT137-1 (SO24)

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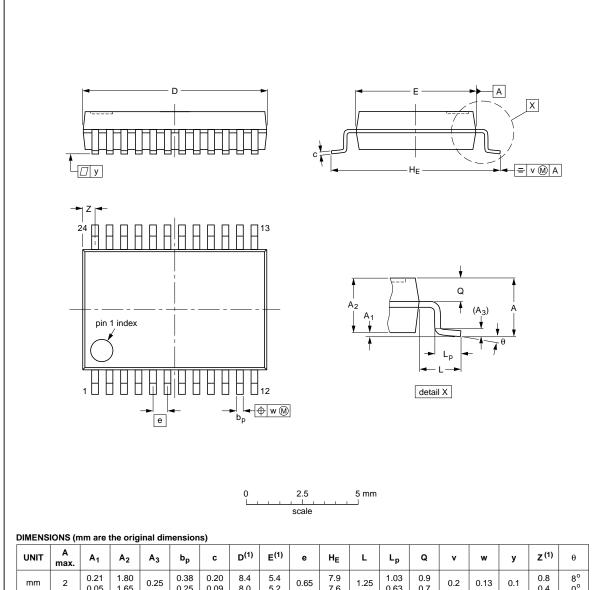
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#### SSOP24: plastic shrink small outline package; 24 leads; body width 5.3 mm

SOT340-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	C	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	v	w	у	z <sup>(1)</sup>	θ
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	8.4 8.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	0.8 0.4	8° 0°

1. Plastic or metal protrusions of 0.2 mm maximum per side are not included.

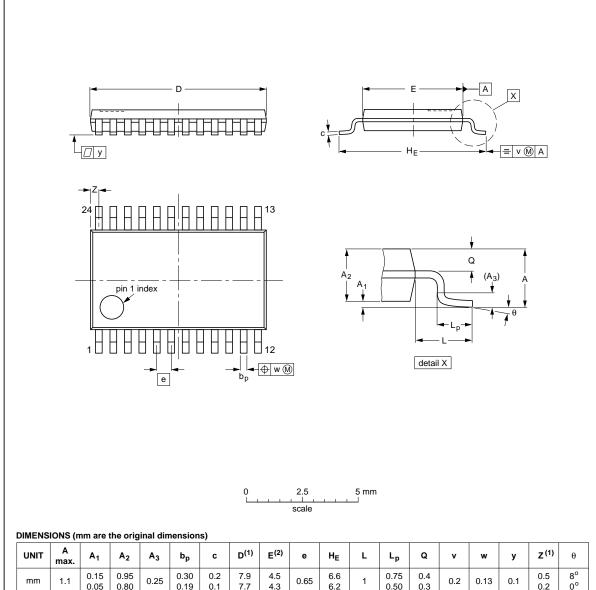
OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT340-1		MO-150				<del>99-12-27</del> 03-02-19	

Fig 11. Package outline SOT340-1 (SSOP24)

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SOT355-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	7.9 7.7	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

	OUTLINE		REFER	EUROPEAN	ISSUE DATE		
	VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
	SOT355-1		MO-153				<del>99-12-27</del> 03-02-19
Į						7	03-02-

Fig 12. Package outline SOT355-1 (TSSOP24)

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### 13. Abbreviations

#### Table 9. Abbreviations

Acronym	Description
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model

## 14. Revision history

#### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT823 v.4	20111107	Product data sheet	-	74ABT823 v.3
Modifications:	<ul> <li>Legal pages</li> </ul>	updated.		
74ABT823 v.3	20100323	Product data sheet	-	74ABT823 v.2
74ABT823 v.2	20050207	Product specification	-	74ABT823 v.1
74ABT823 v.1	19960314	Product specification	-	

#### 9-bit D-type flip-flop with reset and enable; 3-state

### 15. Legal information

#### 15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <a href="http://www.nxp.com">http://www.nxp.com</a>.

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